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Application/Control No.	Applicant(s)/Patent under Reexamination
10/786,121	BIWA ET AL.
Examiner	Art Unit
Hoang M. Nguyen	3748

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60	516, 643, 650, 721	9/12/2007	ĤMN	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

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